

Search Notes



Application/Control No.

10/779,758

Examiner

Mark H. Paschall

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	739 722 723 724	12/10/05	LM
	494		
	412-414		
292	53 44		
	52		
	Dig 69		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Est		
12/10/05	12/10/05	LM